Power MOSFET

30 V, 12.3 A, Single N-Channel, SO-8

Features

- Low R_{DS(on)}
- Low Gate Charge
- Standard SO-8 Single Package
- Pb-Free Package is Available

Applications

- Notebooks, Graphics Cards
- Synchronous Rectification
- High Side Switch
- DC-DC Converters

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage	V _{DSS}	30	V		
Gate-to-Source Voltage	V_{GS}	±20	>		
Continuous Drain	Steady	T _A = 25°C	I _D	10	Α
Current (Note 1)	State	T _A = 85°C		7.3	
	t ≤ 10 s	$T_A = 25^{\circ}C$		12.3	
Power Dissipation (Note 1)	Steady State	T _A = 25°C	P _D	1.6	8
	t ≤ 10 s			2.3	
Continuous Drain	Steady	$T_A = 25^{\circ}C$	I _D	7.6	Α
Current (Note 2)	State	T _A = 85°C		5.4	
Power Dissipation (Note 2)		T _A = 25°C	P_{D}	0.86	W
Pulsed Drain Current	Pulsed Drain Current t _p = 10 μs				Α
Operating Junction and S	Tյ, T _{stg}	-55 to 150	ç		
Source Current (Body Did	2.3	Α			
Single Pulse Drain-to-So (V _{DD} = 25 V, V _{GS} = 10 V, L = 10 mH, R _G = 25 Ω)	E _{AS}	200	mJ		
Lead Temperature for So (1/8" from case for 10 sec	TL	260	°C		

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	80.5	°C/W
$Junction-to-Ambient - t \le 10 s (Note 1)$	$R_{\theta JA}$	55	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	145	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- Surfacemounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
- 2. Surfacemounted on FR4 board using the minimum recommended pad size.

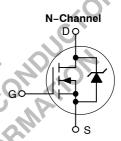


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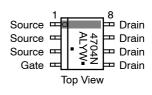
V _{(BR)DSS}	R _{DS(ON)} TYP	I _D MAX	
30 V	7.5 mΩ @ 10 V	12.3 A	
	10 mΩ @ 4.5 V	12.3 A	



MARKING DIAGRAM/ PIN ASSIGNMENT



SO-8 CASE 751 STYLE 12



4704N = Device Code

A = Assembly Location

L = WaferLot Y = Year

WW = Work Week
■ Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMS4704NR2	SO-8	2500/Tape & Reel
NTMS4704NR2G	SO-8 (Pb-Free)	2500/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure. BRD8011/D.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition	on	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 2	50 μΑ	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				28		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V 0VV 04V	T _J = 25°C			www.D	ataShe
		V _{GS} = 0 V, V _{DS} = 24 V	T _J = 125°C			50	1
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} =				±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 2$	250 μΑ	1.0		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D =	12.3 A		7.5	9.5	mΩ
		V _{GS} = 4.5 V, I _D =	: 10 A		10	12.5	1
Forward Transconductance	9FS	V _{DS} = 15 V, I _D =	10 A		20		S
CHARGES, CAPACITANCES AND GATE I	RESISTANCE		<u> </u>		5.	-	<u>-</u>
Input Capacitance	C _{iss}		14		1225	ŀ	pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = 1.0 MHz,	V _{DS} = 20 V	0,	580		
Reverse Transfer Capacitance	C _{rss}		0/,"(0.0	125		
Total Gate Charge	$Q_{G(TOT)}$	700			12	17	nC
Threshold Gate Charge	Q _{G(TH)}		(S) (C)		1.6		
Gate-to-Source Charge	Q _{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}, I_D = 10 \text{ A}$			3.25		1
Gate-to-Drain Charge	Q_{GD}	6,00			5.25		
Gate Resistance	R _G	"C" 'IL.	7		1.8		Ω
SWITCHING CHARACTERISTICS (Note 4)		7,10,6					
Turn-On Delay Time	t _{d(on)}				8.2		ns
Rise Time	t _r	V _{GS} = 10 V, V _{DD} = 15 \	/, I _D = 1.0 A,		5.4		
Turn-Off Delay Time	t _{d(off)}	$R_G = 3.0 \Omega$			28.4		
Fall Time	t _f				10.5		
DRAIN-SOURCE DIODE CHARACTERIST	ics O					<u>-</u>	<u> </u>
Forward Diode Voltage	V _{SD}	, ov.	T _J = 25°C		0.75	1.0	V
5	OK	$V_{GS} = 0 \text{ V}, I_{S} = 2.3 \text{ A}$	T _J = 125°C		0.56		1
Reverse Recovery Time	t _{RR}	V_{GS} = 0 V, d_{IS}/d_t = 100 A/ μ s, I_S = 2.3 A			35		ns
Charge Time	t _a				18		
Discharge Time	t _b				17		1
Reverse Recovery Charge	Q _{RR}				33		nC

Pulse Test: pulse width = 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES

35

 $V_{DS} \ge 10 \text{ V}$

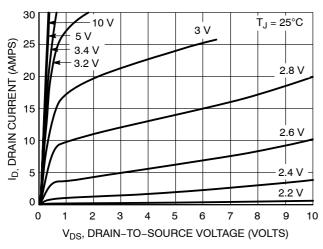
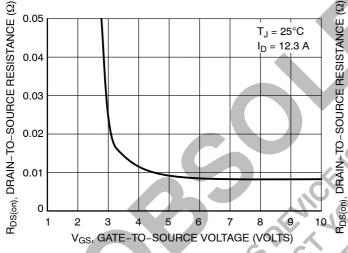


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



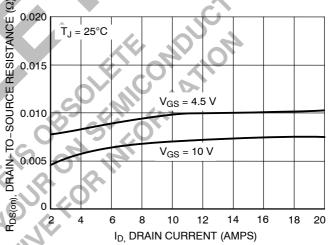
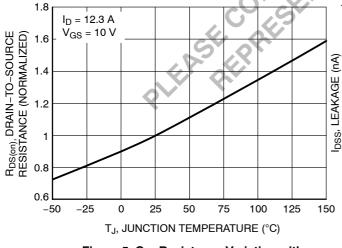


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On–Resistance vs. Drain Current and Gate Voltage



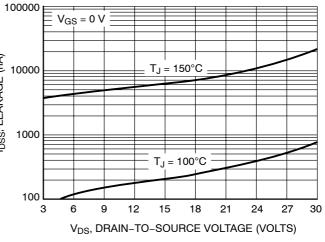
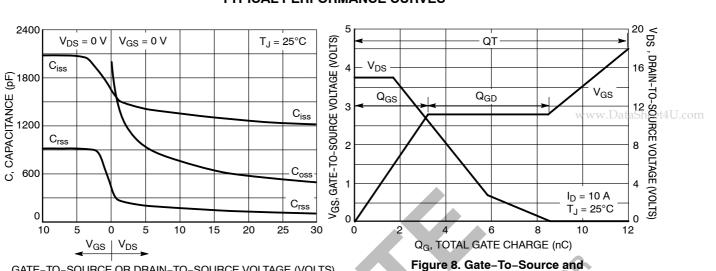


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL PERFORMANCE CURVES



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

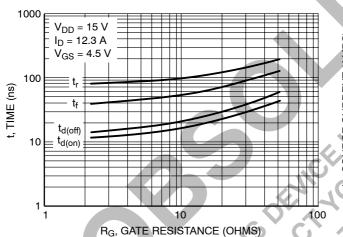
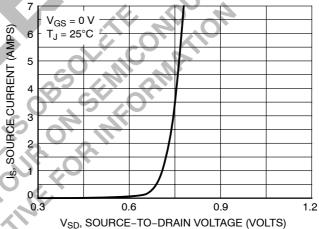


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

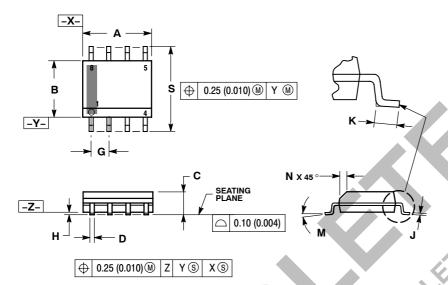


Drain-To-Source Voltage vs. Total Charge

Figure 10. Diode Forward Voltage vs. Current

PACKAGE DIMENSIONS

SOIC-8 CASE 751-07 **ISSUE AG**



NOTES:

- DIMENSIONING AND TOLERANCING PER Sheet 4U.com ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: MILLIMETER. DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07

		MILLIN	IETERS	HES			
	DIM	MIN MAX		MIN	MAX		
	Α	4.80	5.00	0.189	0.197		
	В	3.80	4.00	0.150	0.157		
	С	1.35	1.75	0.053	0.069		
	D	0.33	0.51	0.013	0.020		
	G	1.27	7 BSC	0.05	0 BSC		
	н	0.10 0.25		0.004	0.010		
Þ	J	0.19	0.25	0.007	0.010		
4	K	0.40	1.27	0.016	0.050		
	M	000	8 °	0 °	8 °		
	N	0.25	0.50	0.010	0.020		
P	S	5.80	6.20	0.228	0.244		

- SOURCE
- SOURCE
- SOURCE GATE
- DRAIN
- DRAIN
- DRAIN
- DRAIN

0.6 1.270 SCALE 6:1 0.024 0.050 *For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

4.0 0.155

SOLDERING FOOTPRINT

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